MOSFET – Power, Dual, N-Channel, Power Trench, Power Clip, Asymmetric 25 V



Features

- Small Footprint (5x6mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- These are Pb-free, Halogen Free / BFR Free and are RoHS Compliant

Typical Applications

- DC-DC Converters
- System Voltage Rails

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

	· -		1	,	ı —	
Paran	Sym- bol	Q1	Q2	Unit		
Drain-to-Source Voltag	V_{DSS}	25	25	V		
Gate-to-Source Voltag	V _{GS}	+16V -12V	+16V -12V	٧		
Continuous Drain Cur-	Steady	T _C = 25°C	I _D	74	155	Α
rent R _{θJC} (Note 3)	State	T _C = 85°C		53	112	
Power Dissipation $R_{\theta JC}$ (Note 3)		T _A = 25°C	P _D	25	41	W
Continuous Drain Cur-	Steady	T _A = 25°C	I _D	20	36	Α
rent R _{θJA} (Notes 1, 3)	State	T _A = 85°C		14	26	
Power Dissipation $R_{\theta JA}$ (Notes 1, 3)		T _A = 25°C	P _D	2.1	2.3	W
Continuous Drain Cur-	Steady	T _A = 25°C	I _D	13	24	Α
rent $R_{\theta JA}$ (Notes 2, 3)	State	T _A = 85°C		10	17	
Power Dissipation $R_{\theta JA}$ (Notes 2, 3)		T _A = 25°C	P _D	0.96	1.0	W
Pulsed Drain Current	T _A = 25°	C, t _p = 10 μs	I_{DM}	325	552	Α
Single Pulse Drain-to-S Energy Q1: I _L = 9.4 A _L Q2: I _L = 20.1 A	E _{AS}	134	604	mJ		
Operating Junction and Storage Temperature Range				–55 t	o 150	°C
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)				26	60	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



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FET	V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
01	3.3 mΩ @ 10 V		74 A
Q1	25 V	4.2 mΩ @ 4.5 V	/4 A
00	25 V	1.1 mΩ @ 10 V	155 A
Q2	25 V	1.33 mΩ @ 4.5 V	100 A



PQFN8 POWER CLIP CASE 483AR

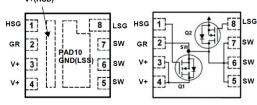
MARKING DIAGRAM

O 2EKN AYWWZZ

2EKN = Specific Device Code A = Assembly Location

Y = Year WW = Work Week ZZ = Assembly Lot Code

ELECTRICAL CONNECTION



ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFD1D4N02P1E	PQFN8 (Pb-Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

Table 1. THERMAL RESISTANCE RATINGS

Parameter	Symbol	Q1 Max	Q2 Max	Units
Junction-to-Case - Steady State (Note 1, 3)	$R_{\theta JC}$	4.4	2.9	°C/W
Junction-to-Ambient - Steady State (Note 1, 3)	$R_{\theta JA}$	60	55	
Junction-to-Ambient - Steady State (Note 2, 3)	$R_{\theta JA}$	130	120	

- 1. Surface-mounted on FR4 board using 1 in² pad size, 2 oz Cu pad.
- 2. Surface-mounted on FR4 board using minimum pad size, 2 oz Cu pad.
- The entire application environment impacts the thermal resistance values shown. They are not constants and are only valid for the particular conditions noted. Actual continuous current will be limited by thermal & electro–mechanical application board design. R_{θCA} is determined by the user's board design.
- by the user's board design.

 4. Q1 100% UIS tested at L = 0.1 mH, I_{AS} = 16.5 A. Q2 100% UIS tested at L = 0.1 mH, I_{AS} = 36 A.

Table 2. ELECTRICAL CHARACTERISTICS (T = 25°C unless otherwise stated)

Parameter	Symbol	Test Condition	FET	Min	Тур	Max	Unit
OFF CHARACTERISTICS							-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	Q1	25			V
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1 mA	Q2	25			V
Drain-to-Source Breakdown Voltage	V _{(BR)DSS} /	BR <u>)</u> DSS / I _D = 250 μA, ref to 25°C			16		mV/°C
Temperature Coefficient	TJ	I _D = 1 mA, ref to 25°C	Q2		19		1
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, V_{DS} = 20 \text{ V}$ $T_{J} = 25^{\circ}\text{C}$	Q1			10	μΑ
			Q2			10	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +16 \text{ V} / -12 \text{ V}$	Q1			±100	nA
		V _{DS} = 0 V, V _{GS} = +16 V / -12 V	Q2			±100	1
ON CHARACTERISTICS (Note 5)	•					•	
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$	Q1	1.2	1.54	2.0	V
		V _{GS} = V _{DS} , I _D = 800 μA	Q2	1.2	1.55	2.0	1
Threshold Temperature Coefficient	$V_{GS,(TH)}$ $I_D = 250 \mu A$, ref to 25°C		Q1		-4.3		mV/°C
	/T _J	I _D = 800 μA, ref to 25°C	Q2		-4.4		7
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 20 A	Q1		2.6	3.3	mΩ
		V _{GS} = 4.5 V, I _D = 18 A	1		3.4	4.2	ヿ
		V _{GS} = 10 V, I _D = 37 A	Q2	0.81	1.1	1	
		V _{GS} = 4.5 V, I _D = 33 A	1		1.04	1.33	1
Forward Transconductance	9FS	V _{DS} = 5 V, I _D = 20 A	Q1		125		
		V _{DS} = 5 V, I _D = 37 A	Q2		285		
Gate Resistance	R_{G}	T _A = 25°C	Q1		0.44		Ω
			Q2		0.6		1
CHARGES & CAPACITANCES							
Input Capacitance	C _{ISS}		Q1		1180		pF
			Q2		3603		
Output Capacitance	C _{OSS}	0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	Q1		320		pF
		$V_{GS} = 0 \text{ V}, V_{DS} = 13 \text{ V}, f = 1 \text{ MHz}$	Q2		940		1
Reverse Capacitance	C _{RSS}		Q1		22		pF
			Q2		64		1

- 5. Pulse Test: pulse width $\leq 300~\mu\text{s},$ duty cycle $\leq 2\%$
- 6. Switching characteristics are independent of operating junction temperatures

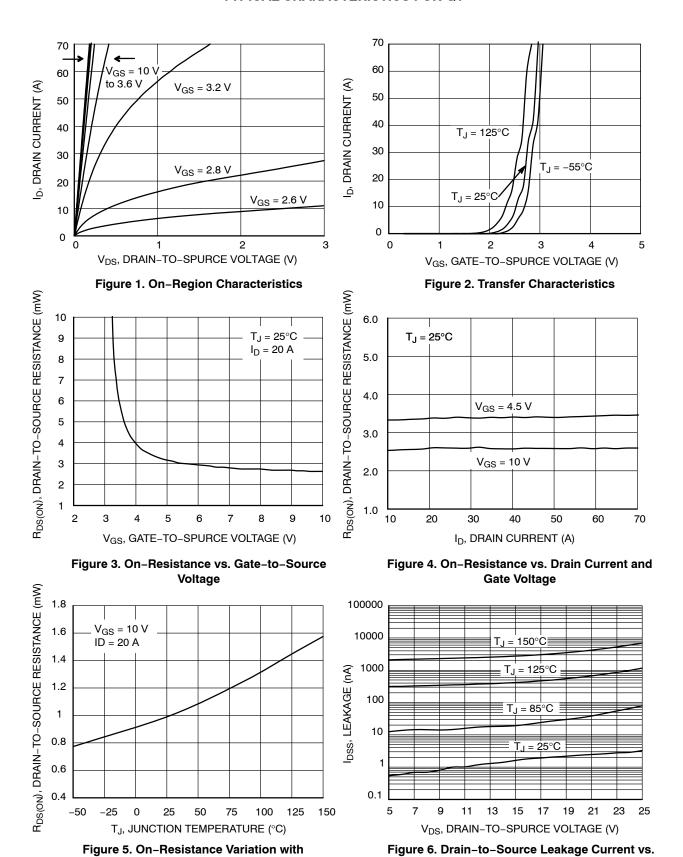
Table 2. ELECTRICAL CHARACTERISTICS (T. = 25°C unless otherwise stated)

Parameter	Symbol	Test Condi	tion	FET	Min	Тур	Max	Unit
CHARGES & CAPACITANCES	•					•		
Total Gate Charge	Q _{G(TOT)}			Q1		7.2		nC
				Q2		21.5		
Gate-to-Drain Charge	Q_{GD}	Q1: V _{GS} = 4.5V, V _{DS} = 13V, I _D = 20A Q2: V _{GS} = 4.5V, V _{DS} = 13V, I _D = 37A		Q1		1.35		nC
				Q2		3.9		
Gate-to-Source Charge	Q_{GS}			Q1		3.15		nC
				Q2		9.1		
Total Gate Charge	$Q_{G(TOT)}$	V _{GS} = 10 V, V _{DS} = 13 V, I _D = 20 A		Q1		16.4		nC
		V _{GS} = 10 V, V _{DS} = 13	V, I _D = 37 A	Q2		48.6		
SWITCHING CHARACTERISTICS	, VGS = 4.5 V (No	ote 6)						
Turn-On Delay Time	t _{d(ON)}			Q1		11.6		ns
						21.4		1
Rise Time	t _{r(ON)}			Q1		2.7		ns
		V _{GS} = 4.5 V		Q2		8.7		
Turn-Off Delay Time	t _{d(OFF)}	Q1: $I_D = 20 \text{ A}$, $V_{DD} = 13 \text{ V}$, $R_G = 6\Omega$ Q2: $I_D = 37 \text{ A}$, $V_{DD} = 13 \text{ V}$, $R_G = 6\Omega$		Q1		15.6		ns
			Q2		30.7			
Fall Time	t _f			Q1		3.2		ns
				Q2		8.5		
SWITCHING CHARACTERISTICS	, VGS = 10 V (No	te 6)						
Turn-On Delay Time	t _{d(ON)}			Q1		7.9		ns
				Q2		10.2		
Rise Time	t _{r(ON)}			Q1		1.1		ns
		V _{GS} = 10 V	2. V.D. 20	Q2		3.3		
Turn-Off Delay Time	t _{d(OFF)}	Q1: $I_D = 20 \text{ A}, V_{DD} = 13 \text{ Q2: } I_D = 37 \text{ A}, V_{DD} = 13 \text{ A}$		Q1		21.3		ns
		Q	,	Q2		48.9		
Fall Time	t _f			Q1		2.2		ns
				Q2		7.4		
SOURCE-TO-DRAIN DIODE CH	ARACTERISTICS	i						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V}, I_{S} = 20 \text{ A}$	T _J = 25°C	Q1		0.8	1.2	V
			T _J = 125°C			0.7		
		$V_{GS} = 0 \text{ V}, I_{S} = 37 \text{ A}$	T _J = 25°C	Q2		0.8	1.2	
			T _J = 125°C			0.65		1
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V,		Q1		21.4		ns
		Q1: I _S = 20 A, dl/dt =		Q2		36.5		1
Reverse Recovery Charge	Q _{RR}	Q2: $I_S = 37 \text{ A}, dI/dt =$	300 A/μS	Q1		8.3		nC
						21.9		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

^{5.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2% 6. Switching characteristics are independent of operating junction temperatures

TYPICAL CHARACTERISTICS FOR Q1



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Voltage

Temperature

TYPICAL CHARACTERISTICS FOR Q1 (continued)

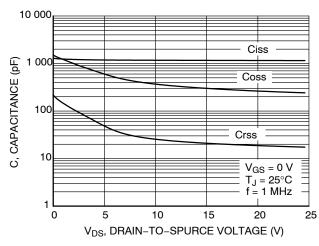


Figure 7. Capacitance Variation

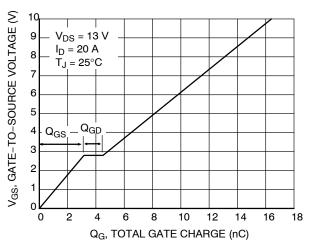


Figure 8. Gate-to-Source vs. Total Charge

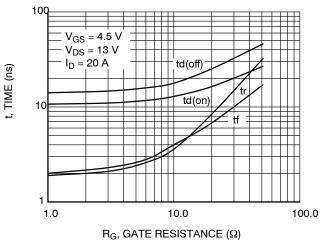


Figure 9. Resistive Switching Time Variation vs.

Gate Resistance

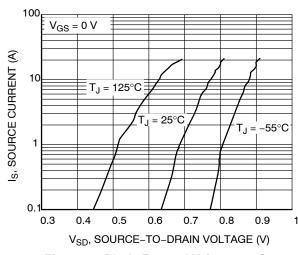


Figure 10. Diode Forward Voltage vs. Current

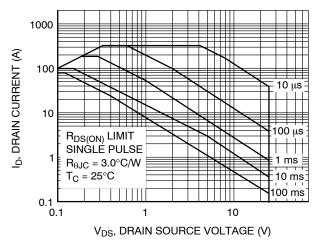


Figure 11. Maximum Rated Forward Biased Safe Operationg Area

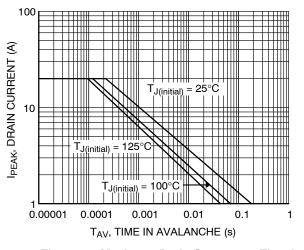


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS FOR Q1 (continued)

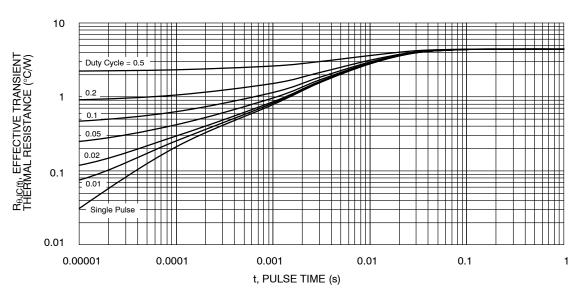


Figure 13. Thermal Response

TYPICAL CHARACTERISTICS FOR Q2

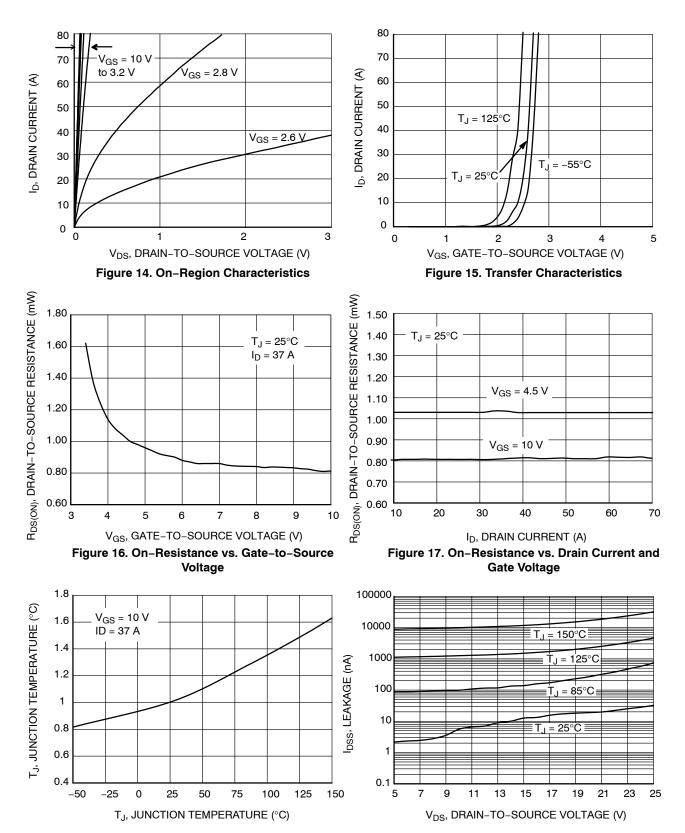


Figure 18. On–Resistance Variation with Temperature

Figure 19. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS FOR Q2 (continued)

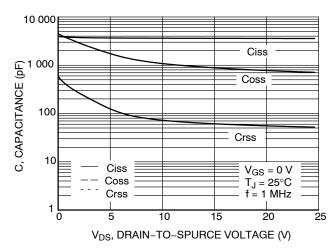


Figure 20. Capacitance Variation

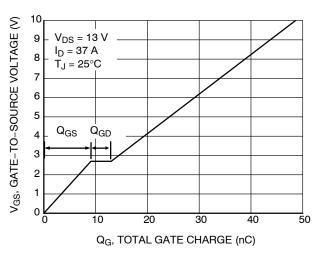


Figure 21. Gate-to-Source vs. Total Charge

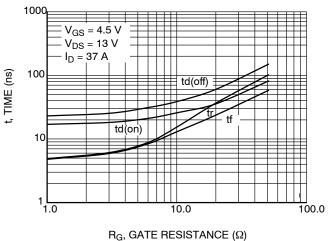


Figure 22. Resistive Switching Time Variation vs.

Gate Resistance

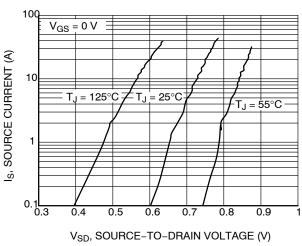


Figure 23. Diode Forward Voltage vs. Current

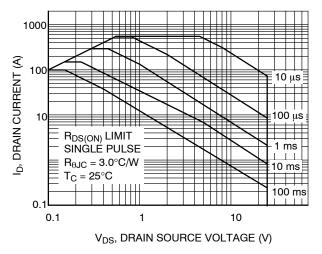


Figure 24. Maximum Rated Forward Biased Safe Operating Area

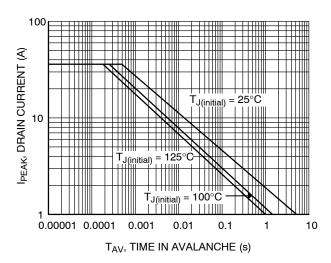


Figure 25. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS FOR Q2 (continued)

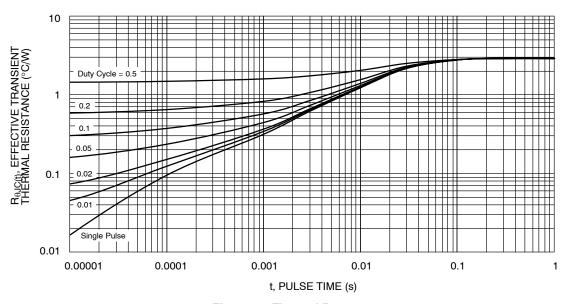


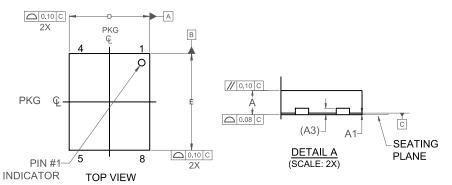
Figure 26. Thermal Response

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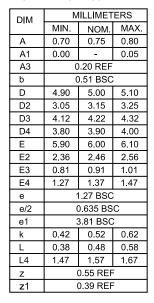
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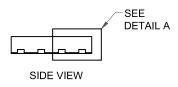
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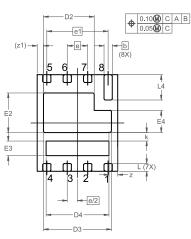


NOTES: UNLESS OTHERWISE SPECIFIED

- A) DOES NOT FULLY CONFORM TO JEDEC REGISTRATION, MO-229, DATED 11/2001.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.







BOTTOM VIEW

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RECOMMENDED LAND PATTERN

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